PCI	N Nu	mber:	PCN	I#202	404120	000.1	).1				PCN D	ate:	April 14, 2024	
Titl	le:	Qualifica	ation	of Cu	as an	alteri	nate bo	ond wi	re for sele	ct de	vices			
Cus	stom	er Conta	ct:	Chan	ge Mai	nage	ment 1	eam	Dept:	Qua	ality Services			
Proposed 1 <sup>st</sup> Ship Date:					July 1	3, 20	024	Sample Requests accepted until:					14, 2024*	
*Sa	ampl	e reques	sts re	eceive	d afte	r Ma	ay 14, 2024 will not be supported.							
	Asse	embly Sit	e				Design				Wafe	Wafer Bump Material		
	Asse	embly Pro	cess				Data Sheet Wafer Bump				p Process			
X Assembly Materials							Part number change				Wafer Fab Site			
Mechanical Specification							Test	t Site Wafer Fab Material				Material		
Packing/Shipping/Labeling					ng		Test	Proces	S		Wafe	r Fab	Process	
	DON D. I. II													

# **PCN Details**

# **Description of Change:**

This PCN is to inform of an alternative bond qualification for the devices in the product affected section as follows:

What	Current	Additional
Current Bond wire, Diameter	Au, 0.96 mil (die to die) + 1.0 mil Cu (die to leadframe)	Cu, 0.8 mil (all)

# **Reason for Change:**

Continuity of supply.

- 1) To align with world technology trends and use wiring with enhanced mechanical and electrical properties
- 2) Maximize flexibility within our Assembly/Test production sites.
- 3) Cu is easier to obtain and stock

# Anticipated impact on Form, Fit, Function, Quality or Reliability (positive / negative):

None

## **Impact on Environmental Ratings**

Checked boxes indicate the status of environmental ratings following implementation of this change. If below boxes are checked, there are no changes to the associated environmental ratings.

RoHS	REACH	Green Status	IEC 62474
No Change	No Change	No Change	No Change

# Changes to product identification resulting from this PCN:

None

## **Product Affected:**

ISO1042BDWV	UCC23113DWYR	UCC23511DWYR	UCC23514EDWVR
ISO1042BDWVR	UCC23313BDWY	UCC23513BDWY	UCC23514MDWV
ISO1042DWV	UCC23313BDWYR	UCC23513BDWYR	UCC23514MDWVR
ISO1042DWVR	UCC23313DWY	UCC23513DWY	UCC23514SDWV
SN23511DWY	UCC23313DWYR	UCC23513DWYR	UCC23514SDWVR

SN23511DWYR	UCC23511BDWY	UCC23513HDWYR	UCC23514VDWV
SN23513DWY	UCC23511BDWYR	UCC23514EDWV	UCC23514VDWVR
SN23513DWYR	UCC23511DWY		

### Qualification Report

#### 8DWV/6DWY ISO.2 full PCC wire qualification Approve Date 23-FEBRUARY -2024

#### **Oualification Results**

Data Displayed as: Number of lots / Total sample size / Total failed

Туре	"	Test Name	Condition	Duration	Qual Device: UCC23513DWY	QBS Reference: UCC23513QDWYRQ1	QBS Reference: UCC23513QDWYQ1	QBS Reference: ISO7741FEDWRQ1	QBS Reference: ISO6721QDWVRQ1	QBS Reference: SN5350MCQDWVRQ1	QBS Reference: ISO6763QDWRQ1	QBS Reference: UCC21540QDWKRQ1
HAST	A2	Blased HAST	130C/85%RH	96 Hours	-	1/77/0	3/231/0	-			3/231/0	1/77/0
UHAST	АЗ	Autoclave	121C/15psig	96 Hours	-	3/231/0	3/231/0	-	1/77/0	3/231/0	3/231/0	3/231/0
тс	A4	Temperature Cycle	-65C/150C	500 Cycles	-	1/77/0	3/231/0		1/77/0	3/231/0	3/231/0	1/77/0
HTSL	A6	High Temperature Storage Life	150C	1000 Hours	-	1/77/0	-	-		5.7.3	3/135/0	1/45/0
HTSL	A6	High Temperature Storage Life	175C	500 Hours	-	u-	3/135/0		-	85%		10583
HTOL	B1	Life Test	125C	1000 Hours	-	I-	3/231/0	1-1	-		-	-
HTOL	B1	Life Test	150C	1000 Hours	-	15.	1.0	3/231/0	-	85%	-	1058
ELFR	B2	Early Life Failure Rate	125C	48 Hours	120	fiz.	3/2400/0	-			2	(2)
ELFR	B2	Early Life Failure Rate	150C	48 Hours	-	II-	i-	3/2400/0	-	(-)	-	(+)
SD	СЗ	PB Solderability	Precondition w155C Dry Bake (4 hrs +/- 15 minutes)	-	-	÷	1/15/0	1/15/0	-	15.0	ē	-
SD	СЗ	PB-Free Solderability	Precondition w.155C Dry Bake (4 hrs +/- 15 minutes)	-		-	1/15/0	1/15/0	-	(*)	-	-
PD	C4	Physical Dimensions	Cpk>1.67		-	3/30/0	3/30/0	3/30/0	-	3/30/0	-	1038
ESD	E2	ESD CDM	12	500 Volts	1020	82	1/3/0	1/3/0	1/3/0	1/3/0	12	120

Туре	"	Test Name	Condition	Duration	Qual Device: UCC23513DWY	QBS Reference: UCC23513QDWYRQ1	QBS Reference: UCC23513QDWYQ1	QBS Reference: ISO7741FEDWRQ1	QBS Reference: ISO6721QDWVRQ1	QBS Reference: SN5350MCQDWVRQ1	QBS Reference: ISO6763QDWRQ1	QBS Reference: UCC21540QDWKRQ1
ESD	E2	ESD HBM	-	2000 Volts	-	- 1	1/3/0	1/3/0	1/3/0	1/3/0	-	-
LU	E4	Latch-Up	Per JESD78	1-	-	-0	1/6/0	1/6/0	1/6/0	1/6/0	9-	-
CHAR	E5	Electrical Distributions	Cpk>1.67 Room, hot, and cold	-	-	1/30/0	3/90/0	3/90/0	1/30/0	3/90/0	3/90/0	3/90/0
FTY	E6	Final Test Yield	-	14-	1/1/0	3/3/0	-0	-	-	-	20/20/0	20/20

- QBS: Qual By Similarity
   Qual Device UCC23513DWY is qualified at MSL2 260C
- Preconditioning was performed for Autoclave, Unbiased HAST, THB/Biased HAST, Temperature Cycle, Thermal Shock, and HTSL, as applicable
  The following are equivalent HTOL options based on an activation energy of 0.7eV: 125C/Ik Hours, 140C/480 Hours, 150C/300 Hours, and 155C/240 Hours
  The following are equivalent HTSL options based on an activation energy of 0.7eV: 150C/Ik Hours, and 170C/420 Hours
  The following are equivalent Temp Cycle options per JESD47: -55C/125C/700 Cycles and -65C/150C/500 Cycles

Quality and Environmental data is available at TI's external Web site: http://www.ti.com/

TI Qualification ID: R-CHG-2310-004

For questions regarding this notice, e-mails can be sent to Change Management team or your local Field Sales Representative.

### **IMPORTANT NOTICE AND DISCLAIMER**

TI PROVIDES TECHNICAL AND RELIABILITY DATA (INCLUDING DATASHEETS), DESIGN RESOURCES (INCLUDING REFERENCE DESIGNS), APPLICATION OR OTHER DESIGN ADVICE, WEB TOOLS, SAFETY INFORMATION, AND OTHER RESOURCES "AS IS" AND WITH ALL FAULTS, AND DISCLAIMS ALL WARRANTIES, EXPRESS AND IMPLIED, INCLUDING WITHOUT LIMITATION ANY IMPLIED WARRANTIES OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE OR NON-INFRINGEMENT OF THIRD PARTY INTELLECTUAL PROPERTY RIGHTS.

These resources are intended for skilled developers designing with TI products. You are solely responsible for (1) selecting the appropriate TI products for your application, (2) designing, validating and testing your application, and (3) ensuring your application meets applicable standards, and any other safety, security, or other requirements. These resources are subject to change without notice. TI grants you permission to use these resources only for development of an application that uses the TI products described in the resource. Other reproduction and display of these resources is prohibited. No license is granted to any other TI intellectual property right or to any third party intellectual property right. TI disclaims responsibility for, and you will fully indemnify TI and its representatives against, any claims, damages, costs, losses, and liabilities arising out of your use of these resources.

TI's products are provided subject to TI's Terms of Sale (<a href="www.ti.com/legal/termsofsale.html">www.ti.com/legal/termsofsale.html</a>) or other applicable terms available either on <a href="ti.com">ti.com</a> or provided in conjunction with such TI products. TI's provision of these resources does not expand or otherwise alter TI's applicable warranties or warranty disclaimers for TI products.